On-Chip Integrated Quantum-Dot–Silicon-Nitride Microdisk Lasers

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Photonic integrated circuits (PICs) offer new ways to manipulate and precisely control photons at the micro- and nanoscale. Mature manufacturing processes from the nanoelectronics industry have enabled PICs to become a cost-effective solution for high-volume applications in information processing and sensing. These circuits also increasingly provide the basis of breakthrough experiments in fundamental optics research on cavity quantum electrodynamics and quantum optics. In this respect, the silicon nitride (SiN) integrated photonics platform stands out because of its seamless transparency from the conventional telecom windows in the near infrared to the blue side of the visible spectrum, and low-loss SiN PICs addressing all regions of this broad wavelength range have been demonstrated.1–7

Practical applications such as on-chip spectroscopy or biosensing require SiN PICs to be extended with active components, the most important of these being compact and tunable lasers. These could be realized through the combination of SiN waveguides with a suitable optical-gain material. Colloidal quantum dots (QDs) offer unique opportunities in this respect. A variety of types of QDs and their 2D counterparts, colloidal quantum wells, have been shown in the past few years to exhibit optical gain at wavelengths that can be readily adjusted from near infrared to visible wavelengths through size quantization and material choice,8–11 and such broadband gain provides for a perfect match with broadband SiN photonics. Various laser devices exploiting these colloidal gain media have been demonstrated, either using accidental ad hoc resonators,12–14 vertical cavities in which gain materials are embedded between reflectors,12–14,15 or individual cavities where QDs are coated on the surface.10–20 Despite the confirmation of QDs as an optical-gain medium in microlasers, the lack of a suitable integration process and limited QD stability have inhibited the development of more complex, fully integrated waveguide-coupled laser sources that could propel PICs into radically new applications.

Fabricating on-chip QD/SiN lasers requires an effective methodology to handle solution-processable QDs within a top-down CMOS (complementary metal oxide semiconductor)–like manufacturing process. Such a process should preserve the optical properties of the QDs and facilitate a strong spatial overlap between the QDs and the resonating optical modes without degrading the optical quality factor (Q) of the hybrid device. Moreover, the QD/SiN resonators need to be coupled with low-loss on-chip waveguides to facilitate efficient extraction and further manipulation of the emitted light. In these respects, the use of SiN membranes with locally embedded QD films within a CMOS-like process flow is a potent approach that allows for the combination of active QD/SiN resonators and passive SiN circuits on the same platform.39,43

Here, we use this approach to demonstrate a first on-chip QD/SiN microdisk laser coupled to planar SiN waveguides. The microdisk consists of a SiN/QD/SiN sandwich that supports high-Q whispering gallery modes (WGMs) with a maximum of optical confinement in the central QD layer. Lasering is achieved for different disk diameters under picosecond optical pumping. The lasing action is characterized via measuring the photoluminescence (PL) intensity versus pump power, and features a nonlinear increase above a very low threshold fluence of 27 μJ cm⁻² for a 7 μm disk. In addition, pronounced spectral narrowing, reduced emission lifetime, and enhanced temporal coherence are observed above the threshold. These ultracompact waveguide-coupled QD/SiN microdisk lasers showcase the key building block for realizing active PICs on the SiN platform.

Figure 1a depicts the proposed device whereby a QD/SiN microresonator is vertically coupled to a passive SiN access waveguide. Design parameters, such as the disk diameter and thickness, the waveguide width, and the coupling offset and gap, are carefully chosen to enable a low lasing threshold and efficient waveguide coupling (see Section S1. Supporting Information). Finite-difference time-domain (FDTD) simulations (see the Experimental Section) indicate that a 7 μm × 0.25 μm monolithic SiN disk supports WGMs with a simulated Q factor of ~5 × 10⁵ at 625 nm, the central emission wavelength of the QDs to be integrated. Importantly, the optical mode is over two times more intense in the central section of the disk as compared to its top or bottom. Since the effective index of the QD film and the deposited SiN are similar (see Section S2,
15 nm with respect to the background emission spectrum. This shift is most likely due to reabsorption of emitted light in the QD layer, which is more pronounced at shorter wavelengths (see Section S2, Supporting Information).

The WGM spectra consist of a series of transverse-electric (TE) and transverse-magnetic (TM)-like modes. Both mode families can be distinguished by their Q factors and free spectral range (FSR), with TE modes exhibiting the larger FSR and higher Q factors according to FDTD simulations (see Section S3, Supporting Information). Typically, larger disks and longer wavelengths yield a higher Q factor for the TE modes as can be seen in Figure 2b. The measured values remain well below the simulated ones, and we attribute this discrepancy to a combination of self-absorption (at shorter wavelengths) and scattering losses not accounted for in the simulations. TE mode scattering losses increase strongly with decreasing radius due to a stronger mode overlap with the disk edge. Assuming negligible self-absorption at 660 nm, we estimate that at 630 nm the scattering loss decreases from 160 to 35 cm⁻¹ for a corresponding disk radius increasing from 5 to 15 μm diameter, as shown in Figure 2b. Performance of the gain medium must be sufficient to overcome such losses if the disk is to support lasing modes.

To assess quantitatively the optical-gain characteristics of the CdSe/CdS QDs used here, we first determined the nonlinear absorbance of a CdSe/CdS QD dispersion measured using transient absorption spectroscopy (see Section S4, Supporting Information). Following femtosecond pulsed photoexcitation at 520 nm, we observe optical gain in a 638–655 nm wavelength range at a pump pulse energy of 38.7 μJ cm⁻². By further increasing the pump fluence, this initial gain turns into a broad gain band that extends from 600 to 674 nm with a material gain peaking at 930 cm⁻¹ at a wavelength of 623 nm. As population inversion lasts for more than 80 ps and the concomitant

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**Figure 1.** Device design and fabrication. a) Vertical coupling configuration of a QD/SiN disk and an access waveguide. A layer of QDs is embedded in the SiN disk. b) Optical microscopy image and SEM image of a fabricated device. Top panel: optical photography of an array of devices on the chip. Middle: top view SEM image of a selected device. Bottom: false-colored SEM image of the waveguide-disk cross section.

**Figure 2.** Characterization of disk WGMs at CW pump. a) Measured PL spectra of disks with different diameters together with background emission, excited by a CW 400 nm laser. b) Measured Q factors for the first-order TE WGMs near three selected wavelengths for disks of different diameters together with extracted scattering loss coefficient. Details of the analysis can be found in Section S3 (Supporting Information).
transient absorbance decays at a rate of 4 ns⁻¹ (see Section S4, Supporting Information), we attribute optical gain in these QDs to stimulated emission from biexciton states, where interfacial alloying may somewhat suppress Auger recombination of the biexcitons.[18,19,34]

Next we determined the modal gain of waveguides defined in a SIN/QD/SIN stack identical to that used for realizing the microdisks. Figure 3a shows the optical emission of a waveguide defined by etching a SIN/QD/SIN stack similar to that used in the resonators and having dimensions of 600 μm in length and 5 μm in width. Upon pumping the waveguide using 400 nm femtosecond pulsed laser light focused by a cylindrical lens to a rectangular stripe, a broadband spontaneous emission spectrum is recorded from the cleaved edge of the waveguide. Increasing pump power leads to a marked narrowing and amplification of the spontaneous emission (ASE). The superlinear intensity increase saturates at a pump power \( 1.8 \) times above threshold power \( P_{\text{ASE}} \) and the corresponding ASE spectrum is centered at \( 627 \) nm with a full-width at half-maximum (FWHM) of \( \approx 8 \) nm. Consequently, we conclude that our process flow for the SIN/QD/SIN stacks preserves the gain characteristics of the CdSe/CdS QDs.

In order to quantify this gain, we analyzed the emission from several SIN/QD/SIN waveguides with dissimilar lengths while maintaining a constant pump power density. Observation of Figure 3b reveals a sharp, superlinear rise in emission intensity for waveguides longer than \( \approx 200 \) μm that saturates for lengths exceeding \( \approx 400 \) μm. We estimate the net modal gain \( g \) by fitting the distance-dependent intensity to \( I = A_0 (g - 1)^{b^{(2)}} \) within the region of exponential intensity increase. Averaged over several sets of nominally identical waveguides, net modal gains of around \( 70 \) cm⁻¹ and \( 100-120 \) cm⁻¹ are obtained for pump powers of about \( 1.4 \times P_{\text{ASE}} \) and \( 2 \times P_{\text{ASE}} \), respectively. The resulting numbers are in line with expectations. Considering a modal confinement of 23% and QD volume filling factor of \( \approx 53\% \), these correspond to a material gain of up to \( 980 \) cm⁻¹. This is comparable to the material gain as deduced from the transient absorption spectra (see Section S4, Supporting Information), suggesting that the additional nonradiative recombination pathways induced by SiN deposition have little influence on stimulated emission by the QDs. More importantly, it indicates that lasing in QD/SIN microdisks should be feasible as the modal gain can exceed the aforementioned cavity losses. Finally, it should be mentioned that we did not observe ASE development in the QD/SIN waveguide with \( \approx 25 \) nm thick QD layer, indicating that such a layer provides insufficient gain. While this suggests that gain coefficient can be simply enhanced by increasing the QD film thickness, such a strategy has its limits as it compromises the quality of the SIN/QD/SIN processing.

To analyze the occurrence of lasing in the QD/SIN microdisks, we optically pump the disks with a pulsed laser at a wavelength of 400 nm (see the Experimental Section). The pump light is coupled into a multimode fiber and then focused to a \( \approx 12 \) μm diameter spot on the chip with a nearly flat-top intensity profile and a 10 ps pulse duration. Typical emission spectra of a 7 μm diameter disk under different excitation conditions are represented in Figure 4a (the laser characterization of larger disks can be found in Section S5, Supporting Information). Below the threshold (0.89 \( P_{\text{th}} \)), the spectrum exhibits typical WGMs within the envelope of the broadband spontaneous emission of the colloidal QDs. By increasing the pump fluence above the threshold (1.16 \( P_{\text{th}} \)), a sharp, 40-fold increase of the intensity for the WGM near 629 nm is observed. This is accompanied by line-narrowing from 0.58 to 0.14 nm FWHM, a distinct characteristic of the onset of lasing. Polarization analysis of the PL spectrum provides additional evidence that the lasing mode is a first-order TE WGM (see Section S6, Supporting Information). By further increasing the pump intensity to 1.8 \( P_{\text{th}} \), a second lasing mode appears at shorter wavelength (near 620 nm), consistent with the blueshift of the gain spectrum with increasing pump power (see S4, Supporting Information). The transition to lasing concurs with the emergence of scattered light of the WGMs in the PL image of the disk (see insets of Figure 4a). In Figure 4b, we plot the total output intensity versus the pump fluence, also known as light-in-light-out (L-L) curve. The laser threshold \( P_{\text{th}} \) was determined to be 27 ± 2 μJ cm⁻². Additionally, the log-scale L-L results for two lasing modes presented in the inset in Figure 4b are well-defined S-shaped curves, which can be accurately fitted by a static rate equation model (see Section S7, Supporting Information).

Stimulated emission is expected to shorten the luminescence decay time. We therefore performed time-resolved PL measurements, and Figure 4c shows the PL decay traces for different pump fluences. The extracted lifetimes dramatically decrease from a few nanoseconds below \( P_{\text{th}} \) to tens of picoseconds above \( P_{\text{th}} \), which is a value limited by the time resolution of the photon counter. Using a streak camera to precisely record the temporally and spectrally resolved dynamics, we find that the emission from the 7 μm disk lasts for about 7 and 11 ps (FWHM) for the short- and long-wavelength modes, respectively (see Figure 4d).
A key signature of lasing is the extended coherence of the emitted photons. The degree of temporal coherence of the laser light is characterized by the first-order correlation $g^{(1)}(\tau)$. By sending the light emitted from the waveguide end facets through a Michelson interferometer, we determine $g^{(1)}(\tau)$ from the interference fringe visibility $V = |g^{(1)}(\tau)|$, where $\tau$ is now the time delay between the two interferometer arms. We measure the interference pattern below and above the threshold, and the results are reported in Figure 5. Below the lasing threshold, the envelope of the visibility can be approximately fitted with a single-exponential decay, resulting in a $1/e$ coherence time of $\tau_c = 0.33$ ps. This short coherence time equals the photon lifetime in the microresonator that can be calculated by $\tau_c = Q/(\omega_0)$, using the measured $Q$ of $1000$ at $630$ nm in $7 \mu m$ diameter disks. Above the lasing threshold, the coherence time increases by almost one order of magnitude to $\tau_c = 2.5$ ps. This nearly equals the measured duration of the emitted laser pulse, but is slightly reduced due to a small temporal emission wavelength chirp from transients in the charge carrier density caused by the pulsed excitation scheme. The fringe pattern extends over the whole waveguide facet (see inset in Figure 5b), as the single-transversal-mode design leads to perfect spatial coherence. A common feature both below and above the threshold is that the multi-longitudinal-mode emission gives rise to a beat note where the peculiar ultrafast THz oscillation frequency corresponds to the frequency difference between the cavity modes (see inset in Figure 5b). The almost Fourier-limited coherence, also in the multimode regime without noticeable mode competition, highlights the quality of the integrated QDs as excellent gain material.

The QD/SiN disk lasers preserve their properties over many weeks of measurements without significant degradation, wavelength drift, or stability issues. This long-term stability is largely attributed to the efficient encapsulation of the colloidal QDs by the SiN matrix. Furthermore, the fabrication process is highly reproducible, allowing for a high device yield (90%) while the operating wavelength has a variability of less than one nanometer for nominally identical devices. We have created a versatile technology that enables hybrid integration of a whole class of solution-processable QDs with the SiN photonics platform. The quantitative analysis...
of the cavity and gain material allows for precise modeling and forecast of the actual device performance thanks to the stable fabrication process. Our device is the first waveguide-coupled colloidal QD laser and operates with an extremely low optical pump threshold of $P_{th} = 27 \mu J \ cm^{-2}$ in only 7 nm diameter disk at room temperature. We show a comprehensive characterization covering spectroscopic, temporal, and coherence properties of these ultracompact lasers. These results constitute a clear demonstration that wavelength-tunable, colloidal QDs can pave the way for versatile, active PICs for lab-on-a-chip, optofluidics, and sensing technologies. The achieved device stability together with excellent device-to-device and chip-to-chip reproducibility is critically important for high-volume fabrication and integration in practical applications. In future devices, we expect that the threshold could be lowered even more by a further optimization of the core/shell QDs, and by switching from a top pump to a waveguide-coupled pump, which would allow for extremely efficient, fully-integrated excitation schemes. Furthermore, the insensitivity of colloidal QD gain to temperature could be exploited to operate active PICs even in harsh environments.

### Experimental Section

**Simulation and Fabrication:** For simulation of the disk WGM, we used a freely available FDTD software package in cylindrical coordinates. For device fabrication, all SiN layers were deposited using a standard plasma-enhanced chemical vapor deposition (PECVD) system operating at a temperature of 270 °C. The PECVD system is equipped with two RF frequency sources operating at, respectively, high frequency (13.56 MHz) and low frequency (100–460 kHz). All the SiN layers were prepared using low frequency, except for the top SiN layer of the SiN/QD/SiN sandwich, which was deposited using a mixed frequency mode to reduce the stress in the SiN layer. Contact optical lithography was employed to define the SiN waveguide and disk patterns with photoresist as mask. The SiR and SiN/QD/SiN layers were etched with an anisotropic reactive ion etching process using a CF$_4$/H$_2$ gas mixture.

**Laser Characterization:** The excitation light at a wavelength of $\lambda = 400$ nm is provided by a frequency-doubled regenerative amplifier seeded with a mode-locked Ti:sapphire laser, resulting in an initial pulse duration of 100–200 fs with a repetition rate of 1 kHz. The light is then coupled into a multimode optical fiber with 25 μm core diameter and 100 cm length, which stretches the pulse duration to ~10 ps and leads to homogenization of the beam profile towards a flat top. The output facet of the pump fiber is imaged demagnified at normal incidence onto the sample by microscope objectives, resulting in an approximately disk-shaped pump spot of 12 μm diameter, and we also confirmed that the beam spot does not contain local hotspots. The intensity of the pump is controlled by a movable gradient filter. For the spectroscopic detection with a high-resolution spectrophotometer and the time-resolved measurements with a time-correlated single-photon counting system, the emitted light is collected with a multimode fiber (200 μm core, numerical aperture NA = 0.22) directly from the cleaved waveguide end facet. For the interferometer, streak camera and polarization-dependent measurements, the light is collected with a microscope objective (NA = 0.3) from the waveguide facet. In the Michelson interferometer, the emitted light is split with a nonpolarizing beam-splitter cube, controllably delayed in one arm by a hollow retroreflector, which is mounted on a motorized linear stage, then recombined and focused on a cooled CCD.

### Supporting Information

Supporting Information is available from the Wiley Online Library or from the author.

### Acknowledgements

This work was supported by the EU commission through the ERC-ULPPIc, H2020-MSCA PHONSI and ICT-NAOLCHI projects, by the Belgian IAP programme through the Photonics@be network and by the Swiss State Secretariat for Education, Research and Innovation (SERI) through the H2020-MSCA PHONSI project. The authors also thank Steven Versuyft for help with optical index measurement and Richard Penny for proofreading the manuscript.

Received: September 9, 2016
Revised: December 23, 2016
Published online:

Advanced Materials

Early View (Online Version of Record published before inclusion in an issue)
Editor-in-Chief: Peter Gregory, Deputy Editors: Mary De Vito, Ducttuo Liang, Leena Söderström
Online ISSN: 1521-4086

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Communications

High Temperature-Stable Perovskite Solar Cell Based on Low-Cost Carbon Nanotube Hole Contact

Bingbing Cao, Xiaoming Zhang, Chao Zhao, Qi Kang, Saihong Gao, Wei Ge, Min Hao, Wei Liu, Xinping Ding, Xiaohui Zheng, Xi Chen, Lijun Shi, Qiuming Zhang, Bing Sun, Nianwen Zhang, and Zongyi Jin

A perovskite solar cell with carbon nanotube-based hole contact and drop cast

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